

I²C-bus controlled 4×45 W power amplifier with six voltage regulators

Rev. 02 — 18 August 2009

Product data sheet

1. General description

1.1 Amplifiers

The TDF8551J has a complementary quad audio power amplifier that uses BCDMOS technology. It contains four amplifiers configured in Bridge-Tied Load (BTL) to drive four speakers: two front and two rear channels. The I²C-bus enables diagnostic information of each amplifier and its speaker to be read separately. Both front and both rear channel amplifiers can be configured independently in line driver mode with a gain of 20 dB (differential output) or amplifier mode with a gain of 26 dB (BTL output).

1.2 Voltage regulators and switches

The TDF8551J has six output voltage regulators and two power switches:

- Four switchable regulators and two standby regulators
- Two power switches with loss-of-ground protection and surge protection
- Second supply pin to reduce dissipation by means of an external DC-to-DC converter
- Backup functionality for regulator 2

2. Features

- Amplifiers
 - I²C-bus control
 - Can drive a 2 Ω load with a battery voltage of up to 16 V and a 4 Ω load with a battery voltage of up to 18 V
 - DC load detection: open, short and present
 - AC load (tweeter) detection
 - Programmable clip detect; 1 % or 3 %
 - Programmable thermal protection pre-warning
 - Independent short-circuit protection for each channel
 - Selectable line driver (20 dB) and amplifier mode (26 dB)
 - Loss-of-ground and open V_P safe
 - ◆ All outputs protected from short-circuit to ground, to V_P or across the load
 - All pins protected from short-circuit to ground
 - Soft thermal-clipping to prevent audio holes
 - Low battery detection
- Voltage regulators and switches
 - I²C-bus control



- Good stability for any regulator with almost any output capacitor value
- Six voltage regulators (microcontroller, display, audio processor, tuner, bus, mechanical digital and drive)
- Selectable output voltages for regulators 1, 4 and 5
- Low dropout voltage PNP output stages
- High supply voltage ripple rejection
- Low noise for all regulators
- Two power switches (antenna switch and amplifier switch)
- Standby regulators 2 and 6 (microcontroller and bus supply) operational during load dump and thermal shutdown
- Low standby quiescent current (regulators 2 and 6 operational only)
- Second supply pin for connecting optional external DC-to-DC converter to reduce internal dissipation
- Backup functionality for regulator 2
- Protection
 - If connection to the battery voltage is reversed, all regulator voltages will be zero
 - Withstands output voltages up to 18 V (supply line may be short-circuited)
 - Thermal protection to avoid thermal breakdown
 - Load dump protection
 - Regulator outputs protected from DC short-circuit to ground or to supply voltage
 - All regulators protected by foldback current limiting
 - Power switches protected from loss-of-ground and surge conditions

3. Applications

Boost amplifier and voltage regulator for car radios and CD/MD players

4. Quick reference data

Table 1.	Quick reference da	Ita					
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Amplifie	rs						
V _{P(oper)}	operating supply voltage	$R_L = 4 \Omega$	[1]	8	14.4	18	V
I _{q(tot)}	total quiescent current	no load		-	280	400	mA
P _{o(max)} max	P _{o(max)} maximum output power	R_L = 4 $\Omega;~V_P$ = 14.4 V; V_{IN} = 2 V RMS square wave		39	41	-	W
		R_L = 4 $\Omega;~V_P$ = 15.2 V; V_{IN} = 2 V RMS square wave		44	46	-	W
		R_L = 2 $\Omega;~V_P$ = 14.4 V; V_{IN} = 2 V RMS square wave		64	69	-	W
THD	total harmonic distortion	P_{o} = 1 W to 12 W; f = 1 kHz; R_{L} = 4 Ω		-	0.01	0.1	%
V _{n(o)} output noise voltag		filter 20 Hz to 22 kHz; R_s = 600 Ω					
		line driver mode		-	25	35	μV
		amplifier mode		-	50	70	μV

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4×45 W power amplifier with six voltage regulators

Table 1.	Quick reference da	atacontinued				
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Voltage i	regulators					
VP	supply voltage	regulators 1, 3, 4 and 5 on; switches 1 and 2 on	10	14.4	18	V
		jump starts for t \leq 10 minutes	-	-	30	V
		load dump protection for $t \leq 50 \text{ ms}$ and $t_r \geq 2.5 \text{ ms}$	-	-	50	V
V _{th(dis)}	disable threshold voltage	regulator 1, 3, 4 and 5 on; switches 1 and 2 on	18.1	22	-	V
V _{DCDC}	DC-to-DC converter voltage		4.75	5.0	VP	V
q _(tot)	total quiescent current	Standby mode; V _P = 14.4 V	-	180	250	μA
V _{O(reg)}	regulator output	regulator 1; 0.5 mA \leq I_O \leq 400 mA; 10 V \leq V_P \leq 18 V				
	voltage	IB2[D3:D2] = 01	7.9	8.3	8.7	V
		IB2[D3:D2] = 10	8.1	8.6	9.1	V
		IB2[D3:D2] = 11	4.75	5.0	5.25	V
		regulator 2; 0.5 mA \leq I_O \leq 350 mA; 10 V \leq V_P \leq 18 V	3.1	3.3	3.5	V
		regulator 3; 0.5 mA \leq I_O \leq 525 mA; 5 V \leq V_{DCDC} \leq 18 V	3.1	3.3	3.5	V
		regulator 4; 0.5 mA \leq I_O \leq 800 mA; 10 V \leq V_P \leq 18 V				
		IB2[D7:D5] = 001	4.75	5.0	5.25	V
		IB2[D7:D5] = 010	5.7	6.0	6.3	V
		IB2[D7:D5] = 011	6.6	7.0	7.4	V
		IB2[D7:D5] = 100	8.1	8.6	9.1	V
		IB2[D7:D5] = 101	7.6	8.0	8.4	V
		regulator 5; 0.5 mA $\leq I_O \leq$ 400 mA				
		10 V \leq V _P \leq 18 V; IB1[D7:D4] = 0001	5.7	6.0	6.3	V
		10 V \leq V _P \leq 18 V; IB1[D7:D4] = 0010	6.65	7.0	7.37	V
		10 V \leq V _P \leq 18 V; IB1[D7:D4] = 0011	7.8	8.2	8.6	V
		$10.5 \text{ V} \le \text{V}_{\text{P}} \le 18 \text{ V}; \text{ IB1[D7:D4]} = 0100$	8.55	9.0	9.45	V
		11 V \leq V _P \leq 18 V; IB1[D7:D4] = 0101	9.0	9.5	10.0	V
		11.5 V \leq V _P \leq 18 V; IB1[D7:D4] = 0110	9.5	10.0	10.5	V
		13 V \leq V _P \leq 18 V; IB1[D7:D4] = 0111	9.9	10.4	10.9	V
		14.2 V \leq V _P \leq 18 V; IB1[D7:D4] = 1000	11.8	12.5	13.2	V
		$12.5 \text{ V} \le \text{V}_{\text{P}} \le 18 \text{ V}; \text{ IB1[D7:D4]} = 1001$	$V_{P}-1$	$V_P - 0.5$	-	V
		10 V ≤ V _P ≤ 18 V; IB1[D7:D4] = 1010	4.75	5.0	5.25	V
		10 V ≤ V _P ≤ 18 V; IB1[D7:D4] = 1011	3.1	3.3	3.5	V
		regulator 6; 0.5 mA \leq I_O \leq 100 mA; 10 V \leq V_P \leq 18 V	4.75	5.0	5.25	V
Power s	witches					
V _{do}	dropout voltage	switch 1; $I_0 = 400 \text{ mA}$	-	0.6	1.1	V
		switch 2; I _O = 400 mA	-	0.6	1.1	V

 Table 1.
 Quick reference data ... continued

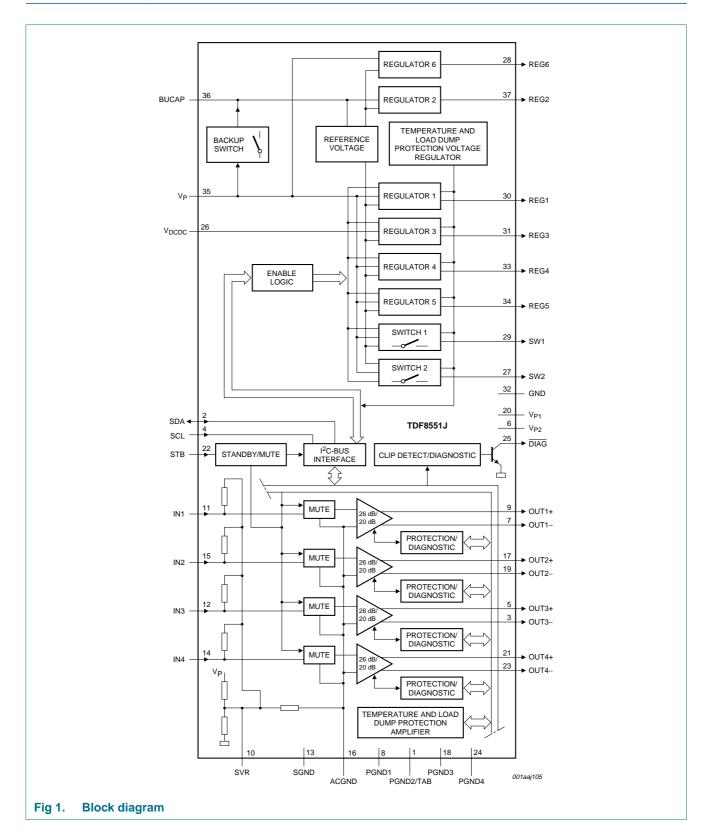
[1] voltage on pin V_{p1} and/or pin V_{p2}

5. Ordering information

Table 2. Ordering information					
Type number	Package				
	Name	Description	Version		
TDF8551J	DBS37P	plastic DIL-bent-SIL power package; 37 leads (lead length 6.8 mm)	SOT725-1		

 $4\,{\times}\,45$ W power amplifier with six voltage regulators

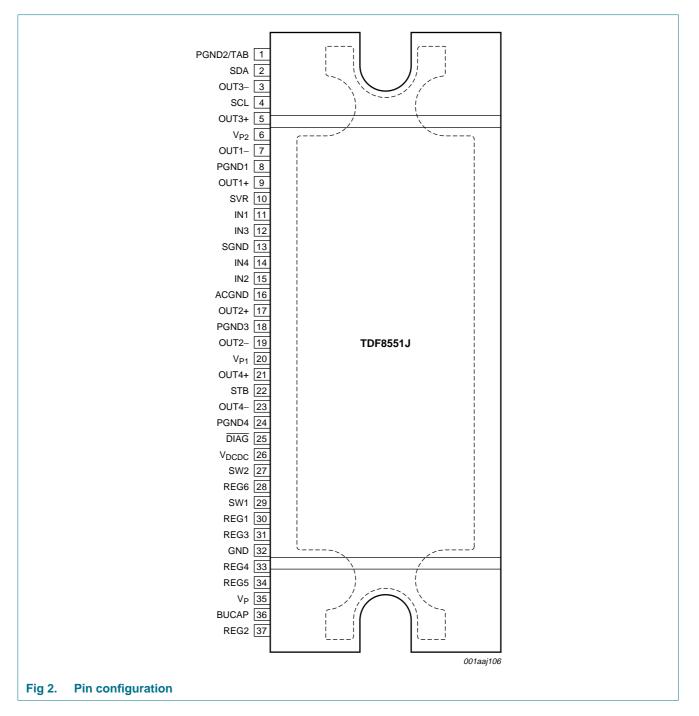
6. Block diagram



 4×45 W power amplifier with six voltage regulators

7. Pinning information

7.1 Pinning



7.2 Pin description

Pin description		
Pin	Description	
3 1	power ground 2 and connection for heatsink	
2	I ² C-bus data input and output	
3	channel 3 negative output	
4	I ² C-bus clock input	
5	channel 3 positive output	
6	power supply voltage 2 to amplifiers	
7	channel 1 negative output	
8	power ground 1	
9	channel 1 positive output	
10	half supply voltage filter capacitor	
11	channel 1 input	
12	channel 3 input	
13	signal ground	
14	channel 4 input	
15	channel 2 input	
16	AC ground	
17	channel 2 positive output	
18	power ground 3	
19	channel 2 negative output	
20	power supply voltage 1 to amplifiers	
21	channel 4 positive output	
22	standby, operating or mute mode select input	
23	channel 4 negative output	
24	power ground 4	
25	diagnostic and clip detection output, active-LOW	
26	power supply voltage from optional DC-to-DC converter	
27	antenna switch; supplies unregulated power to car aerial motor	
28	regulator 6 output; supply for bus controller	
29	amplifier switch; supplies unregulated power to amplifiers	
30	regulator 1 output; supply for audio part of radio and CD player	
31	regulator 3 output; supply for signal processor part (mechanical digital) of CD player	
32	combined voltage regulator, power and signal ground	
33	regulator 4 output; supply for mechanical part (mechanical drive) of CD player	
34	regulator 5 output; supply for display part of radio and CD player	
35	power supply to voltage regulators	
36	connection for backup capacitor	
	Pin B 1 2 3 4 5 6 7 8 9 10 11 12 13 14 15 16 17 18 19 20 21 21 22 23 24 25 26 27 28 29 30 31 32 32 33 34 35	

8. Functional description

The TDF8551J is an IC which provides six voltage regulators in combination with four independent, BTL configured, power amplifiers and diagnostic capabilities. All regulator output voltages except regulators 2 and 6 can be controlled via the I²C-bus.

The amplifier diagnostic functions give information about output offset, load, or short-circuit. The diagnostic functions are controlled using the l²C-bus. The TDF8551J is protected against short-circuit, overtemperature, open ground and open V_P connections. If a short-circuit occurs at the output of a single amplifier, that channel shuts down and the other channels continue to operate normally. The short-circuited channel can be switched off by the microcontroller using the appropriate enable bit of the l²C-bus to prevent any noise generated by the fault condition from being heard.

8.1 Start-up

At power on, regulators 2 and 6 reach their final voltage when the backup capacitor voltage exceeds 5.5 V, independently of the voltage on pin STB. When pin STB is LOW, the total quiescent current is low and the l^2 C-bus lines are high-impedance.

When pin STB is HIGH, the I²C-bus is biased on and the TDF8551J performs a power-on reset. When bit IB1[D0] is set, the amplifier is activated, DB2[D7] (power-on reset occurred) is reset and pin $\overline{\text{DIAG}}$ is no longer held LOW.

8.2 Start-up and shutdown timing

See Figure 12.

A capacitor connected to pin SVR enables smooth start-up and shutdown, preventing the amplifier from producing audible clicks at switch-on or switch-off. The start-up and shutdown times can be extended by increasing the capacitor value.

If the amplifier is shutdown using pin STB, it is muted, the regulators and switches are switched off, and the capacitor connected to pin SVR discharges. The low-current Standby mode is activated 2 seconds after pin STB goes LOW.

8.3 Power-on reset and supply voltage spikes

See Figure 13 and Figure 14.

If the supply voltage drops too low to guarantee the integrity of the data in the I^2C -bus latches, the power-on reset cycle will start. All latches will be set to a predefined state, pin DIAG will be pulled LOW to indicate that a power-on reset has occurred, and bit DB2[D7] is also set for the same reason. When IB1[D0] is set, the power-on flag resets, pin DIAG is released and the amplifier enters its start-up cycle.

8.4 Diagnostic output

Pin DIAG indicates clipping, thermal protection pre-warning of amplifier and voltage regulator parts, short-circuit protection and low and high battery voltage. Pin DIAG is an active-LOW, open-drain output which must be connected to an external voltage using an external pull-up resistor. If a failure occurs, pin DIAG remains LOW during the failure and no clipping information is available. The microcontroller can read the failure information using the I²C-bus.

8.5 Amplifiers

8.5.1 Muting

Both a hard mute and a soft mute can be performed using the I^2 C-bus. A hard mute mutes the amplifier within 0.5 ms. A soft mute mutes the amplifier within 20 ms and is less audible. A hard mute is also activated if a voltage of 8 V is applied to pin STB.

8.5.2 Temperature protection

If the average junction temperature rises to the temperature trigger value that has been set using the I^2C -bus, a thermal protection pre-warning is activated making pin \overline{DIAG} LOW. If the temperature continues to rise, all four channels are muted to reduce the output power (soft thermal clipping). However, the value at which the temperature mute control activates is fixed; only the temperature at which the thermal protection pre-warning signal occurs can be specified by bit IB3[D4].

If applying the temperature mute control does not reduce the average junction temperature, all the power stages will be switched off (muted) at the absolute maximum temperature $T_{j(max)}$.

8.5.3 Offset detection

Offset detection can only be performed when there is no input signal to the amplifiers, for instance when the external digital signal processor is muted after a start-up. The output voltage of each channel is measured and compared with a reference voltage. If the output voltage of a channel is greater than the reference voltage, bit D2 of the associated data byte is set and read by the microcontroller during a read instruction. Note that the value of this bit is only meaningful when there is no input signal and the amplifier is not muted. Offset detection is always enabled.

8.5.4 Speaker protection

If one side of a speaker is connected to ground, the missing current protection is triggered to prevent damage to the speaker. A fault condition is detected in a channel when there is a mismatch between the power current in the high-side and the power current in the low-side; during a fault condition the channel will be switched off.

The load status of each channel can be read using the I^2C -bus: short to ground (one side of the speaker connected to ground), short to V_P (one side of the speaker connected to V_P) and shorted load.

8.5.5 Line driver mode

An amplifier can be used as a line-driver by switching it to low-gain mode. In normal mode, the gain between single-ended input and differential output (across the load) is 26 dB. In low-gain mode the gain between single-ended input and differential output is 20 dB.

8.5.6 Input and AC ground capacitor values

The negative inputs to all four amplifier channels are combined at pin ACGND. To obtain the best performance of supply voltage ripple rejection and unwanted audible noise, the value of the capacitor connected to pin ACGND must be as close as possible to 4 times the value of the input capacitor connected to the positive input of each channel.

8.5.7 Load detection

8.5.7.1 DC load detection

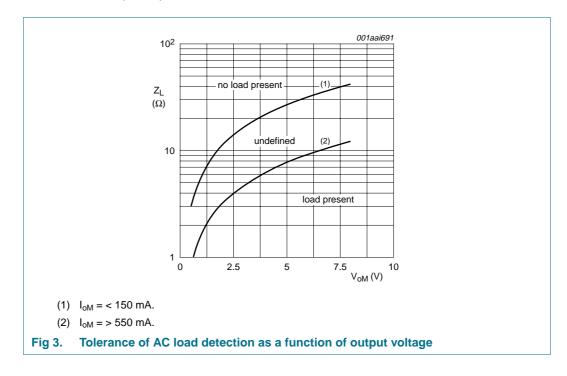
When DC load detection is enabled, during the start-up cycle, a DC-offset is applied slowly to the amplifier outputs and the output currents are measured. If the output current of an amplifier rises above a certain level, it is assumed that there is a load of less than 6 Ω and bit D5 is reset in the associated data byte register to indicate that a load is detected.

The offset is measured during the amplifier start-up cycle which means detection is inaudible and can be performed every time the amplifier is switched on.

8.5.7.2 AC load detection

AC load detection can be used to detect that AC-coupled speakers are connected correctly during assembly. This requires at least 3 periods of a 19 kHz sine wave to be applied to the amplifier inputs. The amplifier produces a peak output voltage which also generates a peak output current through the AC-coupled speaker. The 19 kHz sine wave is also audible during the test. If the amplifier detects three current peaks that are greater than 550 mA, the AC load detection bit is set. Three current peaks are counted to avoid false AC load detection which can occur if the input signal is switched on and off. The peak current counter can be reset by setting bit IB1[D1] to logic 0. To guarantee AC load detection never occurs with a current of less than 150 mA.

Figure 3 shows which AC loads are detected at different output voltages. For example, if a load is detected at an output voltage of 2.5 V peak, the load is less than 4 Ω . If no load is detected, the output impedance is more than 14 Ω .



8.5.7.3 Load detection procedure

- 1. At start-up, enable the AC or DC load detection by setting bit IB1[D1] to logic 1.
- 2. After 250 ms the DC load is detected and the mute is released. This is inaudible and can be implemented each time the IC is powered on.
- 3. When the amplifier start-up cycle is completed (after 1.5 s), apply an AC signal to the input, and DC load bits D5 of each data byte should be read and stored by the microcontroller.
- 4. After at least 3 periods of the input signal, the load status can be checked by reading AC detect bits D4 of each data byte.

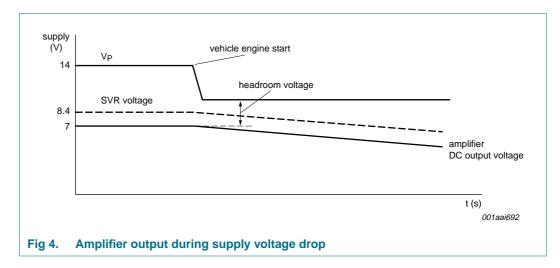
The AC load peak current counter can be reset by setting bit IB1[D1] to logic 0 and then to logic 1. Note that this will also reset the DC load detection bits D5 in each data byte.

8.5.8 Low headroom protection

The normal DC output voltage of the amplifier is set to half the supply voltage and is related to the voltage on pin SVR. An external capacitor is connected to pin SVR to suppress power supply ripple. If the supply voltage drops (at vehicle engine start), the DC output voltage will follow slowly due to the affect of the SVR capacitor.

The headroom voltage is the voltage required for correct operation of the amplifier and is defined as the voltage difference between the level of the DC output voltage before the V_P voltage drop and the level of V_P after the voltage drop (see Figure 4).

At a certain supply voltage drop, the headroom voltage will be insufficient for correct operation of the amplifier. To prevent unwanted audible noises at the output, the headroom protection mode will be activated (see Figure 4). This protection discharges the capacitors connected to pins SVR and ACGND to increase the headroom voltage.



8.6 Voltage regulators and switches

The TDF8551J has six output voltage regulators and two power switches:

- · Four switchable regulators and two standby regulators
- Two power switches with loss-of-ground protection and surge protection

- Second supply pin to reduce dissipation by means of an external DC-to-DC converter
- Backup functionality for regulator 2

The TDF8551J uses low dropout voltage regulators for use in low voltage applications. All of the voltage regulators except for the standby regulators can be controlled using the I^2C -bus.

The TDF8551J also has two power switches which can deliver unregulated continuous current and several fail-safe protection modes.

It conforms to peak transient tests and protects against continuous high voltage (24 V), short-circuits and thermal stress. Standby regulators 2 and 6 will try to maintain output for as long as possible even if a thermal shutdown or any other fault condition occurs. During overvoltage stress conditions, all outputs except regulators 2 and 6 will switch-off and the device will be able to supply a minimum current for an indefinite amount of time sufficient for powering the memory of a microcontroller and bus controller functionality. Provision is made for an external reserve supply capacitor to be connected to pin BUCAP which can store enough energy to allow regulator 2 to supply a microcontroller for a period long enough for it to prepare for a loss-of-voltage.

8.6.1 Standby regulator outputs

Standby outputs (regulators 2 and 6) are used for the microcontroller and bus controller supply. These regulators will not shutdown with the switched regulators and cannot be controlled by the I²C-bus. The standby regulators will not shutdown during load dump transients or by high temperature protection.

8.6.2 Backup capacitor

A backup capacitor (C_{backup}) is used as a backup supply for the regulator 2 output when the battery supply voltage (V_P) cannot support the regulator 2 voltage.

8.6.3 Backup function

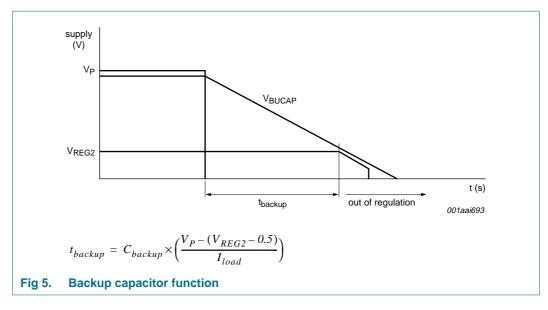
The backup function is implemented by a switch function, which behaves like an ideal diode between pins V_P and BUCAP; the forward voltage of this ideal diode depends on the current flowing through it. The backup function supplies regulator 2 during brief periods when no supply voltage is present on pin V_P. It requires an external capacitor to be connected to pin BUCAP and ground. When the supply voltage is present on pin V_P this capacitor will be charged to a level of V_P – 0.3 V. When the supply voltage is absent from pin V_P, this charge can then be used to supply regulator 2 for a brief period (t_{backup}) calculated using the formula:

$$t_{backup} = C_{backup} \times R_L \times \left(\frac{V_P - (V_{REG2} - 0.5)}{V_{REG2}}\right)$$
(1)

Example: V_P = 14.4 V, V_{REG2} (voltage on pin REG2) = 3.3 V, R_L = 1 k Ω and C_{backup} = 100 μ F provides a t_{backup} of 321 ms.

When an overvoltage condition occurs, the voltage on pin BUCAP is limited to approximately 24 V; see Figure 5.

 4×45 W power amplifier with six voltage regulators



8.6.4 Power switches

There are two power switches that provide an unregulated DC voltage output for amplifiers and an aerial motor respectively. The switches have internal protection for overtemperature conditions and are activated by setting bits IB1[D2] and IB1[D3] to logic 1.

In the ON state, the switches have a low impedance to the battery voltage. When the battery voltage is higher than 22 V, the switches are switched off. When the battery voltage is below 22 V the switches are set to their original condition.

The power switches have built-in surge protection to be able to absorb energy from switching inductive or capacitive external loads. This surge protection is implemented in such a way that in case no supply (V_P) is present the supply line will not be charged from a possible external source connected to a power switch output.

8.6.5 External DC-to-DC converter

The V_{DCDC} supply pin can be connected to an external DC-to-DC down converter ($V_O \ge 5 V$) to reduce the dissipation in regulator 3. If no external DC-to-DC converter is used, the V_{DCDC} pin must be connected to V_P.

8.6.6 Protection

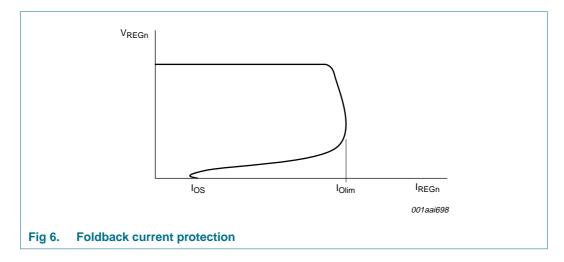
All regulator and switch outputs are fully protected by foldback current limiting against load dumps and short-circuits; see Figure 6. During a load dump all regulator outputs, except the output of regulators 2 and 6, will go low.

The power switches can withstand 'loss-of-ground'. This means that if pin GND becomes disconnected, the switch is protected by automatically connecting its outputs to ground.

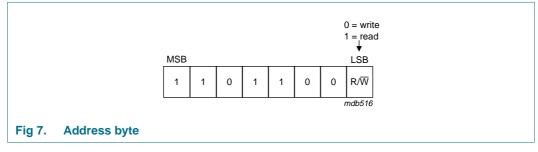
8.6.7 Temperature protection

If the junction temperature of a regulator becomes too high, the amplifier(s) are switched off to prevent unwanted noise signals being audible. A regulator junction temperature that is too high is indicated by pin DIAG going LOW and is also indicated by setting bit DB2[D6].

If the junction temperature of the regulator continues to rise and reaches the maximum temperature protection level, all regulators and switches will be disabled except regulators 2 and 6.



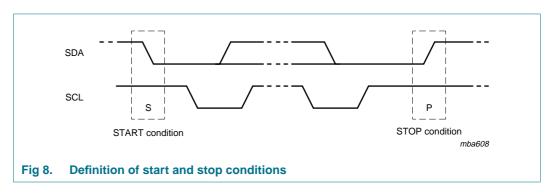
8.7 I²C-bus specification



If address byte bit $R/\overline{W} = 0$, the TDF8551J expects three instruction bytes: IB1, IB2 and IB3; see <u>Table 1</u> to <u>Table 6</u>.

After a power-on, all instruction bits are set to zero.

If address byte bit R/W = 1, the TDF8551J will send four data bytes to the microcontroller: DB1, DB2, DB3 and DB4; see Table 7 to Table 10.



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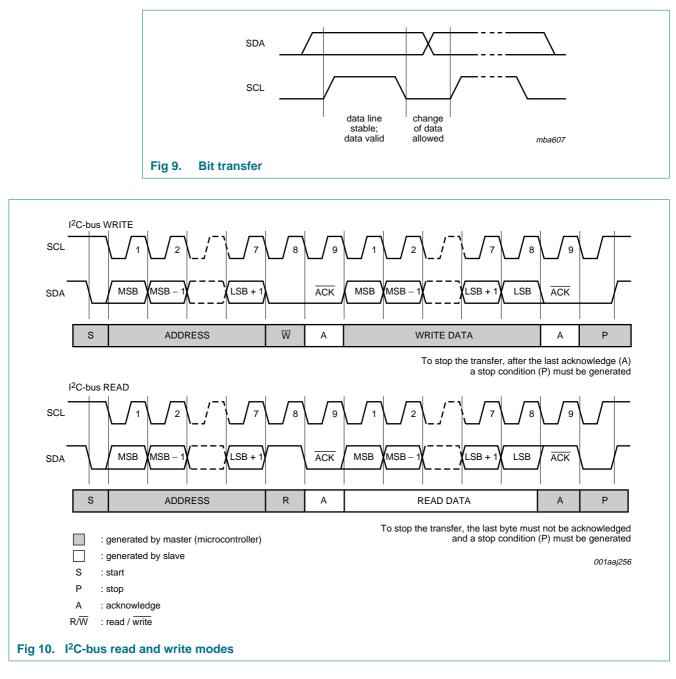


Table 4.	Instruction by	yte IB1 bit description	
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Bit	Symbol	Description
DIL	Symbol	Description
7	D7	regulator 5 output voltage control; see Table 5
6	D6	
5	D5	
4	D4	
3	D3	SW2 control
		0 = SW2 off
		1 = SW2 on

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Table 4.	Instruction b	yte IB1 bit descriptioncontinued
Bit	Symbol	Description
2	D2	SW1 control
		0 = SW1 off
		1 = SW1 on
1	D1	AC load or DC load detection switch
		0 = AC load or DC load detection off; resets DC load detection bits and AC load detection peak current counter
		1 = AC load or DC load detection on
0	D0	amplifier start enable (clear power-on reset flag DB2[D7])
		$0 = $ amplifier off; pin \overline{DIAG} remains LOW
		1 = amplifier on; when power-on occurs, bit DB2[D7] is reset and pin DIAG is released

Table 5. Regulator 5 (display) output voltage control

Bit		Output (V)		
D7	D6	D5	D4	
0	0	0	0	0 (off)
0	0	0	1	6.0
0	0	1	0	7.0
0	0	1	1	8.2
0	1	0	0	9.0
0	1	0	1	9.5
0	1	1	0	10.0
0	1	1	1	10.4
1	0	0	0	12.5
1	0	0	1	$\leq V_P - 1$ (switch)
1	0	1	0	5.0
1	0	1	1	3.3

Table 6. Instruction byte IB2 bit description

Bit	Symbol	Description
7	D7	regulator 4 output voltage control; see Table 7
6	D6	
5	D5	
4	D4	regulator 3 (mechanical digital) control
		0 = regulator 3 off
		1 = regulator 3 on
3	D3	regulator 1 output voltage control; see Table 8
2	D2	
1	D1	soft mute all amplifier channels (mute delay 20 ms)
		0 = mute off
		1 = mute on

4×45 W power amplifier with six voltage regulators

Table 6.	Instruction byte IB2 bit description continued			
Bit	Symbol	Description		
0 D0		hard mute all amplifier channels (mute delay 0.4 ms)		
		0 = mute off		
		1 = mute on		

Table 7. Regulator 4 (mechanical drive) output voltage control

Bit	Output (V)		
D7	D6	D5	
0	0	0	0 (off)
0	0	1	5
0	1	0	6
0	1	1	7
1	0	0	8.6
1	0	1	8.0

Table 8. Regulator 1 (audio) output voltage control

Bit		Output (V)
D3	D2	
0	0	0 (off)
0	1	8.3
1	0	8.6
1	1	5.0

Table 9. Instruction byte IB3 bit description

Tuble J.	mon donom byte	
Bit	Symbol	Description
7	D7	clip detection level
		0 = 3 % detection level
		1 = 1 % detection level
6	D6	amplifier channels 1 and 2 gain select
		0 = 26 dB gain (normal mode)
		1 = 20 dB gain (line-driver mode)
5	D5	amplifier channels 3 and 4 gain select
		0 = 26 dB gain (normal mode)
		1 = 20 dB gain (line-driver mode)
4	D4	amplifier thermal protection pre-warning
		0 = warning at 145 °C
		1 = warning at 122 °C
3	D3	disable channel 1
		0 = enable channel 1
		1 = disable channel 1

4×45 W power amplifier with six voltage regulators

Table 9.	Instruction byte	IB3 bit description continued
Bit	Symbol	Description
2	D2	disable channel 2
		0 = enable channel 2
		1 = disable channel 2
1	D1	disable channel 3
		0 = enable channel 3
		1 = disable channel 3
0	D0	disable channel 4
		0 = enable channel 4
		1 = disable channel 4

Table 10. Instruction byte DB1 bit description

Bit	Symbol	Description
7	D7	amplifier thermal protection pre-warning
		0 = no warning
		1 = junction temperature above pre-warning level
6	D6	amplifier maximum thermal protection
		0 = junction temperature below 175 °C
		1 = junction temperature above 175 °C
5	D5	channel 4 DC load detection
		0 = DC load detected
		1 = no DC load detected
4	D4	channel 4 AC load detection
		0 = no AC load detected
		1 = AC load detected
3	D3	channel 4 load short-circuit
		0 = normal load
		1 = short-circuit load
2	D2	channel 4 output offset
		0 = no output offset
		1 = output offset
1	D1	channel 4 V _P short-circuit
		$0 = no short-circuit to V_P$
		1 = short-circuit to V_P
0	D0	channel 4 short-circuit to ground
		0 = no short-circuit to ground
		1 = short-circuit to ground

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Bit	Symbol	Description
	D7	Power-on reset occurred or amplifier status
		0 = amplifier on
		1 = POR has occurred; amplifier off
6	D6	regulator thermal protection pre-warning
		0 = no warning
		1 = regulator temperature too high; amplifier off
	D5	channel 3 DC load detection
		0 = DC load detected
		1 = no DC load detected
	D4	channel 3 AC load detection
		0 = no AC load detected
		1 = AC load detected
	D3	channel 3 load short-circuit
		0 = normal load
		1 = short-circuit load
	D2	channel 3 output offset
		0 = no output offset
		1 = output offset
	D1	channel 3 V _P short-circuit
		$0 = no short-circuit to V_P$
		1 = short-circuit to V_P
	D0	channel 3 short-circuit to ground
		0 = no short-circuit to ground
		1 = short-circuit to ground

Table 12. Data byte DB3 bit description

Bit	Symbol	Description		
7	D7	-		
6	D6	-		
5	D5	channel 2 DC load detection		
		0 = DC load detected		
		1 = no DC load detected		
4	D4	channel 2 AC load detection		
		0 = no AC load detected		
		1 = AC load detected		
3	D3	channel 2 load short-circuit		
		0 = normal load		
		1 = short-circuit load		
2	D2	channel 2 output offset		
		0 = no output offset		
		1 = output offset		

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Table 12.	Data byte DB3	33 bit descriptioncontinued		
Bit	Symbol	Description		
1	D1	channel 2 V _P short-circuit		
		$0 = no short-circuit to V_P$		
		$1 = $ short-circuit to V_P		
0	D0	channel 2 short-circuit to ground		
		0 = no short-circuit to ground		
		1 = short-circuit to ground		

Table 13. Data byte DB4 bit description

Bit	Symbol	Description
		Description
7	D7	•
6	D6	-
5	D5	channel 1 DC load detection
		0 = DC load detected
		1 = no DC load detected
4	D4	channel 1 AC load detected
		0 = no AC load detected
		1 = AC load detected
3	D3	channel 1 load short-circuit
		0 = normal load
		1 = short-circuit load
2	D2	channel 1 output offset
		0 = no output offset
		1 = output offset
1	D1	channel 1 short-circuit to VP
		$0 = no short-circuit to V_P$
		$1 = $ short-circuit to V_P
0	D0	channel 1 short-circuit to ground
		0 = no short-circuit to ground
		1 = short-circuit to ground

9. Limiting values

Table 14. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Мах	Unit
VP	supply voltage	operating	-	18	V
		not operating	-1	+50	V
		jump starts for $t \le 10$ minutes	-	30	V
		load dump protection for $t \leq 50$ ms and $t_r \geq 2.5$ ms	0	50	V
V _{SDA}	voltage on pin SDA	operating	0	7	V
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Table 14. Limiting values ... continued

In accordance with the Absolute Maximum Rating System (IEC 60134).

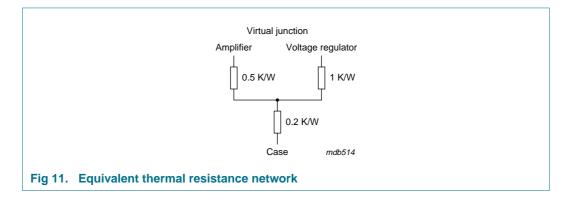
Symbol	Parameter	Conditions	Min	Max	Unit
V _{SCL}	voltage on pin SCL	operating	0	7	V
VI	input voltage	pins INn, SVR, ACGND, DIAG, operating	0	13	V
V _{STB}	voltage on pin STB	operating	0	24	V
I _{OSM}	non-repetitive peak output current		-	10	А
I _{ORM}	repetitive peak output current		-	6	А
V _{P(sc)}	short-circuit supply voltage	across output pin loads and to ground or supply (AC and DC)	-	18	V
V _{P(r)}	reverse supply voltage	voltage regulator only	-	-18	V
P _{tot}	total power dissipation	T _{case} = 70 °C	-	80	W
Tj	junction temperature		-	150	°C
T _{stg}	storage temperature		-55	+150	°C
T _{amb}	ambient temperature		-40	+85	°C
V _{ESD}	electrostatic discharge voltage		<u>[1]</u> _	2000	V
			[2] _	200	V

[1] Human body model: $R_s = 1.5 \text{ k}\Omega$; C = 100 pF; all pins have passed all tests to 2500 V to guarantee 2000 V, according to class II.

[2] Machine model: $R_s = 10 \Omega$; C = 200 pF; L = 0.75 mH; all pins have passed all tests to 250 V to guarantee 200 V, according to class II.

10. Thermal characteristics

Table 15.	Thermal characteristics			
Symbol	Parameter	Conditions	Тур	Unit
R _{th(j-a)}	thermal resistance from junction to ambient	in free air	40	K/W
R _{th(j-c)}	thermal resistance from junction to case	see Figure 11	0.75	K/W



10.1 Quality specification

In accordance with "General Quality Specification for Integrated Circuits SNW-FQ-611D".

11. Characteristics

Table 16. Characteristics

 $T_{amb} = 25 \circ C$; V_{DCDC} ; $V_P = 14.4 V$; $R_L = 4 \Omega$; measured in the test circuit <u>Figure 26</u>; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Мах	Uni
Amplifier						
Supply volta	ge behavior					
V _{P(oper)}	operating supply voltage	$R_L = 4 \Omega$	8	14.4	18	V
		$R_L = 2 \Omega$	8	14.4	16	V
l _{q(tot)}	total quiescent current	no load	-	280	400	mA
stb	standby current		-	10	50	μA
Vo	output voltage	DC	-	7.2	-	V
V _{P(low)(mute)}	low supply voltage mute		6.5	7	8	V
V _{hr}	headroom voltage	when headroom protection is activated; see Figure 4	-	1.4	-	V
V _{POR}	power-on reset voltage	see Figure 13	-	5.5	-	V
V _{O(offset)}	output offset voltage	mute mode and power on	-100	0	+100	mV
Mode select	(pin STB)					
V _{STB}	voltage on pin STB	Standby mode	-	-	1.3	V
		operating mode	2.5	-	5.5	V
		mute mode	8	-	VP	V
I	input current	$V_{STB} = 5 V$	-	4	25	μA
Start-up, shu	utdown and mute timing					
t _{wake}	wake-up time	from standby before first I ² C-bus transmission is recognized; via pin STB; see <u>Figure 12</u>	-	300	500	μs
t _{d(mute_off)}	mute off delay time	via l ² C-bus IB1[D0]; C _{SVR} = 22 μF; see <mark>Figure 12</mark>	-	250	-	ms
d(mute-on)	delay time from mute to on	soft mute; via I ² C-bus IB2[D1] = 1 to 0	10	25	40	ms
		hard mute; via l ² C-bus IB2[D0] = 1 to 0	10	25	40	ms
		via pin STB; V _{STB} = 8 V to 4 V	10	25	40	ms
d(on-mute)	delay time from on to mute	soft mute; via I ² C-bus IB2[D1] = 0 to 1	10	25	40	ms
		hard mute; via l ² C-bus IB2[D0] = 0 to 1	-	0.4	1	ms
		via pin STB; V _{STB} = 4 V to 8 V	-	0.4	1	ms
² C-bus inter	face					
V _{IL}	LOW-level input voltage	on pins SCL and SDA	-	-	1.5	V
VIH	HIGH-level input voltage	on pins SCL and SDA	2.3	-	5.5	V
V _{OL}	LOW-level output voltage	on pin SDA; I _{load} = 3 mA	-	-	0.4	V
SCL	SCL clock frequency		_	_	400	kH

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Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Amplifier dia	gnostics					
V _{OL(DIAG_N)}	LOW-level output voltage on pin DIAG	fault condition (pin LOW); I _{DIAG_N} = 200 μA	-	-	0.8	V
V _{O(offset)}	output offset voltage		±1.5	±2	±2.5	V
THD _{clip}	total harmonic distortion clip detection	IB3[D7] = 0	-	3	-	%
	level	IB3[D7] = 1	-	1	-	%
T _{j(AV)(pwarn)}	pre-warning average junction	IB3[D4] = 0	135	145	155	°C
	temperature	IB3[D4] = 1	112	122	132	°C
T _{j(AV)(mute)}	mute average junction temperature	V_{IN} = 0.05 V; –3 dB muting	150	160	170	°C
T _{j(AV)(off)}	average junction temperature for off	all outputs switched off	165	175	185	°C
ZL	load impedance	DC load detected	-	-	6	Ω
		no DC load detected	500	-	-	Ω
I _{det(load)}	load detection current	AC load detected	550	-	-	mA
		no AC load detected	-	-	150	mA
Amplifier						
Po	output power	$\label{eq:RL} \begin{array}{l} R_L = 4 \; \Omega; \; V_P = 14.4 \; V; \\ THD = 0.5 \; \% \end{array}$	18	19	-	W
		R_L = 4 Ω; V _P = 14.4 V; THD = 10 %	25	26	-	W
		R_L = 2 Ω; V _P = 14.4 V; THD = 0.5 %	27	31	-	W
		R_L = 2 Ω; V _P = 14.4 V; THD = 10 %	40	44	-	W
P _{o(max)}	maximum output power	$R_L = 4 \Omega$; $V_P = 14.4 V$; $V_{IN} = 2 V RMS$ square wave	39	41	-	W
		$R_L = 4 \Omega; V_P = 15.2 V;$ $V_{IN} = 2 V RMS$ square wave	44	46	-	W
		$R_L = 2 \Omega; V_P = 14.4 V;$ $V_{IN} = 2 V RMS$ square wave	64	69	-	W
THD	total harmonic distortion	$P_o = 1 W$ to 12 W; f = 1 kHz; $R_L = 4 \Omega$	-	0.01	0.1	%
		$P_o = 1 \text{ W}$ to 12 W; f = 10 kHz	-	0.2	0.5	%
		P _o = 4 W; f = 1 kHz	-	0.01	0.03	%
		line driver mode; V _o = 2 V (RMS); f = 1 kHz; R _L = 600 Ω	-	0.01	0.03	%
α _{cs}	channel separation	f = 1 Hz to 10 kHz; R _s = 600 Ω	50	60	-	dB
		P _o = 4 W; f = 1 kHz	-	80	-	dB
SVRR	supply voltage rejection ratio	f = 100 Hz to 10 kHz; R _s = 600 Ω	55	70	-	dB
CMRR	common mode rejection ratio	amplifier mode; $V_{cm} = 0.3 V (p-p);$ f = 1 kHz to 3 kHz; R _s = 0 Ω	40	70	-	dB

Table 16. Characteristics ... continued

 $T_{amb} = 25 \,^{\circ}C$: V_{DCDC} : $V_{P} = 14.4 \,^{\circ}V$: $R_{I} = 4 \,^{\circ}\Omega$: measured in the test circuit Figure 26: unless otherwise specified.

Table 16. Characteristics ...continued

 $T_{amb} = 25 \circ C$; V_{DCDC} ; $V_P = 14.4 V$; $R_I = 4 \Omega$; measured in the test circuit Figure 26; unless otherwise specified.

V _{cm(max)(rms)} V _{n(o)}	maximum common mode voltage (rms value) output noise voltage	f = 1 kHz		-	_	0.6	17
V _{n(o)}	output noise voltage				-	0.0	V
		filter 20 Hz to 22 kHz; R _s = 600 Ω					
		line driver mode		-	25	35	μV
		amplifier mode		-	50	70	μV
G _{v(amp)}	voltage gain amplifier mode	single-ended in to differential out		25	26	27	dB
G _{v(ld)}	voltage gain line driver mode	single-ended in to differential out		19	20	21	dB
Zi	input impedance	C _{in} = 220 nF		55	70	-	kΩ
α_{mute}	mute attenuation	V _{O(on)} /V _{o(mute)}		80	90	-	dB
V _{o(mute)}	mute output voltage	V _i = 1 V RMS		-	70	-	μV
Bp	power bandwidth	–1 dB; THD = 1 %		-	20	-	kHz
Voltage regu	llators						
	supply voltage	regulator 1, 3, 4 and 5 on; switches 1 and 2 on		10.0	14.4	18	V
		standby regulator 2 in regulation		5.0	-	50	V
		standby regulator 6 in regulation		6.0	-	50	V
V _{th(dis)}	disable threshold voltage	regulator 1, 3, 4 and 5 on; switches 1 and 2 on		18.1	22	-	V
V _{DCDC}	DC-to-DC converter voltage			4.75	5.0	VP	V
I _{q(tot)}	total quiescent current	Standby mode; $V_P = 14.4 V$	[1]	-	180	250	μA
Regulator 1 a	audio supply: pin REG1; $I_0 = 5$ mA unles	s otherwise specified					
V _{O(reg)}	regulator output voltage	0.5 mA \le I _O \le 400 mA; 10 V < V _P < 18 V					
		IB2[D3:D2] = 01		7.9	8.3	8.7	V
		IB2[D3:D2] = 10		8.1	8.6	9.1	V
		IB2[D3:D2] = 11		4.75	5.0	5.25	V
SVRR	supply voltage rejection ratio	$f_{ripple} = 120 Hz;$ $V_{ripple} = 2 V (p-p)$		50	60	-	dB
V _{do}	dropout voltage	V _P = 7 V; IB2[D3:D2] = 01	[3]				
		l _O = 300 mA		-	0.5	0.8	V
		I _O = 400 mA		-	0.7	1.2	V
I _O	output current	$V_{O} \ge 4 V$	[4]	400	700	-	mA
l _{os}	output short-circuit current	$R_L \le 0.5 \ \Omega$	[5]	100	200	-	mA
Line regulatio	ก						
ΔV _O	output voltage variation	$10 \text{ V} \le \text{V}_{\text{P}} \le 18 \text{ V}$		-	-	50	mV
Load regulati							
ΔV _O	output voltage variation	$5~mA \leq I_O \leq 400~mA$		-	-	100	mV

Table 16. Characteristics ... continued $T_{amb} = 25 \circ C; V_{DCDC}; V_P = 14.4 V; R_L = 4$

40 measured in the test circuit Figure 26 unless otherwise specified

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Regulator 2	2 microprocessor supply: pin REG2; I _C	₀ = 5 mA unless otherwise specifie	d				
V _{O(reg)}	regulator output voltage	0.5 mA \leq I_O \leq 350 mA; 10 V \leq V_P \leq 18 V		3.1	3.3	3.5	V
SVRR	supply voltage rejection ratio	f _{ripple} = 120 Hz; V _{ripple} = 2 V (p-p)		40	50	-	dB
V _{do}	dropout voltage	$V_{BUCAP} = 4.75 V$	[6][8]				
		I _O = 350 mA		-	1.45	2.0	V
lo	output current	$V_O \ge 2.8 V$	<u>[4]</u>	350	1000	-	mA
l _{os}	output short-circuit current	$R_L \le 0.5 \ \Omega$	[5]	160	300	-	mA
Line regula	ition						
ΔV_O	output voltage variation	$10~V \le V_P \le 18~V$		-		50	mV
Load regul	ation						
ΔV_O	output voltage variation	$0.5~mA \leq I_O \leq 350~mA$		-	-	100	mV
Regulator	3 mechanical digital supply: pin REG3	; $I_0 = 5 \text{ mA}$ unless otherwise spec	ified				
V _{O(reg)}	regulator output voltage	0.5 mA \leq I_O \leq 525 mA; 10 V \leq V_P \leq 18 V	<u>[9]</u>	3.1	3.3	3.5	V
		$5 \text{ V} \leq \text{V}_{\text{DCDC}} \leq 18 \text{ V}$					
SVRR	supply voltage rejection ratio	f _{ripple} = 120 Hz; V _{ripple} = 2 V (p-p)		50	65	-	dB
V _{do}	dropout voltage	$V_{DCDC} = 4.75 \text{ V}; \text{ I}_{O} = 525 \text{ m/s}$	<u>[2][8]</u>	-	1.45	2.0	V
lo	output current	$V_{O} \ge 2.8 V$	[4]	525	900	-	mA
l _{os}	output short-circuit current	$R_L \le 0.5 \Omega$	[5]	180	350	-	mA
Line regula	ntion						
ΔV_O	output voltage variation	$5 \text{ V} \leq \text{V}_{\text{DCDC}} \leq 18 \text{ V}$		-	3	50	mV
Load regul	ation						
ΔV_O	output voltage variation	$0.5 \text{ mA} \le I_O \le 525 \text{ mA}$		-	-	100	mV
Regulator 4	4 mechanical drive supply: pin REG4;	$I_{O} = 5$ mA unless otherwise specif	ied				
V _{O(reg)}	regulator output voltage	0.5 mA \leq I_O \leq 800 mA; 10 V \leq V_P \leq 18 V					
		IB2[D7:D5] = 001		4.75	5.0	5.25	V
		IB2[D7:D5] = 010		5.7	6.0	6.3	V
		IB2[D7:D5] = 011		6.6	7.0	7.4	V
		IB2[D7:D5] = 100		8.1	8.6	9.1	V
		IB2[D7:D5] = 101		7.6	8.0	8.4	V
SVRR	supply voltage rejection ratio	f _{ripple} = 120 Hz; V _{ripple} = 2 V (p-p)		50	65	-	dB
V _{do}	dropout voltage	V _P = 7 V; IB2[D7:D5] = 011	[3]				
		l _O = 500 mA		-	0.5	0.8	V
		I _O = 800 mA		-	0.7	1.2	V
I _{OM}	peak output current	$T \le 3 s; V_0 = 4 V$		1	1.5	-	А
lo	output current	$V_O \ge 4 V; T \le 100 ms;$ $V_P \ge 11.5 V$	<u>[4]</u>	1.5	2	-	А

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Table 16. Characteristics ...continued

 T_{amb} = 25 °C; V_{DCDC} ; V_P = 14.4 V; R_L = 4 Ω ; measured in the test circuit Figure 26; unless otherwise specified.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
l _{os}	output short-circuit current	$R_L \le 0.5 \ \Omega$	[5]	240	400	-	mA
Line regula	tion						
ΔV _O	output voltage variation	$10 \text{ V} \le \text{V}_{\text{P}} \le 18 \text{ V}$		-	3	50	mV
Load regula	ation						
ΔV_O	output voltage variation	$0.5 \text{ mA} \le I_O \le 800 \text{ mA}$		-	-	100	mV
Regulator 5	5 display supply: pin REG5; I _O = 5 mA	unless otherwise specified					
V _{O(reg)}	regulator output voltage	$0.5 \text{ mA} \le I_O \le 400 \text{ mA}$					
		$10 V \le V_P \le 18 V;$ IB1[D7:D4] = 0001		5.7	6.0	6.3	V
		$10 V \le V_P \le 18 V;$ IB1[D7:D4] = 0010		6.65	7.0	7.37	V
		$10 V \le V_P \le 18 V;$ IB1[D7:D4] = 0011		7.8	8.2	8.6	V
		$10.5 V \le V_P \le 18 V;$ IB1[D7:D4] = 0100		8.55	9.0	9.45	V
		$11 \text{ V} \le \text{V}_{P} \le 18 \text{ V};$ IB1[D7:D4] = 0101		9.0	9.5	10.0	V
		11.5 V \leq V _P \leq 18 V; IB1[D7:D4] = 0110		9.5	10.0	10.5	V
		$13 V \le V_P \le 18 V;$ IB1[D7:D4] = 0111		9.9	10.4	10.9	V
		14.2 V \leq V _P \leq 18 V; IB1[D7:D4] = 1000		11.8	12.5	13.2	V
		12.5 V ≤ V _P ≤ 18 V; IB1[D7:D4] = 1001		V _P – 1	$V_P - 0.5$	-	V
		$10 V \le V_P \le 18 V;$ IB1[D7:D4] = 1010		4.75	5.0	5.25	V
		$10 V \le V_P \le 18 V;$ IB1[D7:D4] = 1011		3.1	3.3	3.5	V
SVRR	supply voltage rejection ratio	f _{ripple} = 120 Hz; V _{ripple} = 2 V (p-p)		50	60	-	dB
V _{do}	dropout voltage	V _P = 7 V; IB1[D7:D4] = 0010	[3]				
		I _O = 300 mA		-	0.5	0.8	V
		I _O = 400 mA		-	0.7	1.2	V
lo	output current	$V_O \ge 2.8 V$	[4]	400	900	-	mA
los	output short-circuit current	$R_L \le 0.5 \ \Omega$	[5]	150	300	-	mA
Line regula	tion						
ΔV _O	output voltage variation	$10~V \leq V_P \leq 18~V$		-	3	50	mV
Load regula	ation						
ΔV _O	output voltage variation	$0.5 \text{ mA} \leq I_O \leq 400 \text{ mA}$		-	-	100	mV
Regulator 6	δ bus control supply: pin REG6; I _O = 5	mA unless otherwise specified					
V _{O(reg)}	regulator output voltage	0.5 mA \leq I_O \leq 100 mA; 10 V \leq V_P \leq 18 V		4.75	5.0	5.25	V

$4\,{\times}\,45$ W power amplifier with six voltage regulators

Table 16. Characteristics ...continued

 $T_{amb} = 25 \circ C$; V_{DCDC} ; $V_P = 14.4 V$; $R_L = 4 \Omega$; measured in the test circuit Figure 26; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
SVRR	supply voltage rejection ratio	f _{ripple} = 120 Hz; V _{ripple} = 2 V (p-p)	40	50	-	dB
V _{do}	dropout voltage	$V_P = 4.75 \text{ V}; I_O = 100 \text{ mA}$	<u>[3]</u>	0.4	0.8	V
lo	output current	$V_{O} > 4.0 V$	^[4] 150	350	-	mA
los	output short-circuit current	R_L < 0.5 Ω	<u>5</u> 50	125	-	mA
Line regula	tion					
ΔV_O	output voltage variation	$10~V \le V_P \le 18~V$	-	3	50	mV
Load regula	ation					
ΔV_O	output voltage variation	$0.5 \text{ mA} \le I_O \le 100 \text{ mA}$	-	-	100	mV
Power swite	ch 1 antenna: pin SW1					
V _{do}	dropout voltage	I _O = 300 mA	-	0.6	0.8	V
		I _O = 400 mA	-	0.6	1.1	V
lo	output current	$V_O \ge 8.5 V$	[4] 0.5	1	-	А
l _{os}	output short-circuit current	$R_L \le 0.5 \ \Omega$	<u>[5]</u>	250	-	mA
IL	leakage current	$V_{O} = 18 \text{ V}; V_{P} = 0 \text{ V}$	[7] _	25	250	μA
Power swite	ch 2 amplifier: pin SW2					
V _{do}	dropout voltage	I _O = 300 mA	-	0.6	0.8	V
		I _O = 400 mA	-	0.6	1.1	V
lo	output current	$V_O \ge 8.5 V$	[4] 0.5	1	-	А
l _{os}	output short-circuit current	$R_L \le 0.5 \ \Omega$	<u>[5]</u>	250	-	mA
IL	leakage current	$V_{O} = 18 \text{ V}; V_{P} = 0 \text{ V}$	[7] _	25	250	μA
Backup swi	tch					
I _{bu}	backup current (DC)	$V_{BUCAP} \ge 6 V$	0.4	1.5	-	А
V _{CL}	clamping voltage	V _P = 30 V; I _{O(reg2)} = 100 mA	-	24	28	V
	dropout voltage	$I_0 = 500 \text{ mA}; (V_P - V_{BUCAP})$		0.8	1.2	V

[1] The quiescent current is measured in Standby mode when $R_L = \infty$.

[2] The dropout voltage of regulator 3 is the voltage difference between V_{DCDC} and V_{O(reg)}.

[3] The dropout voltage of a regulator is the voltage difference between V_P and $V_{O(req)}$.

[4] At current limit, $V_{O(reg)}$ is held constant; see Figure 6.

[5] The foldback current protection limits the dissipation power at short-circuit; see Figure 6.

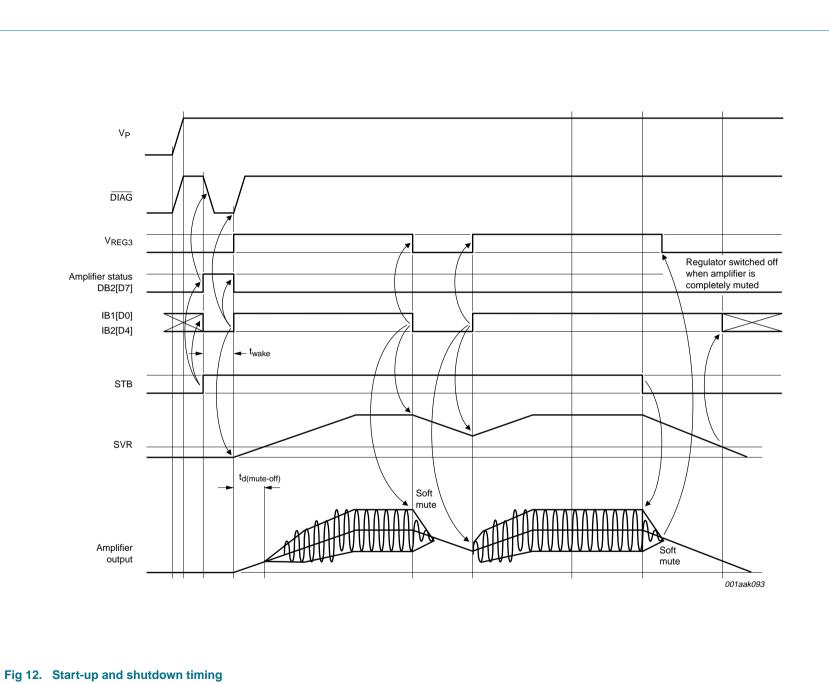
[6] The dropout voltage of regulator 2 is the voltage difference between V_{BUCAP} and $V_{O(reg)}$.

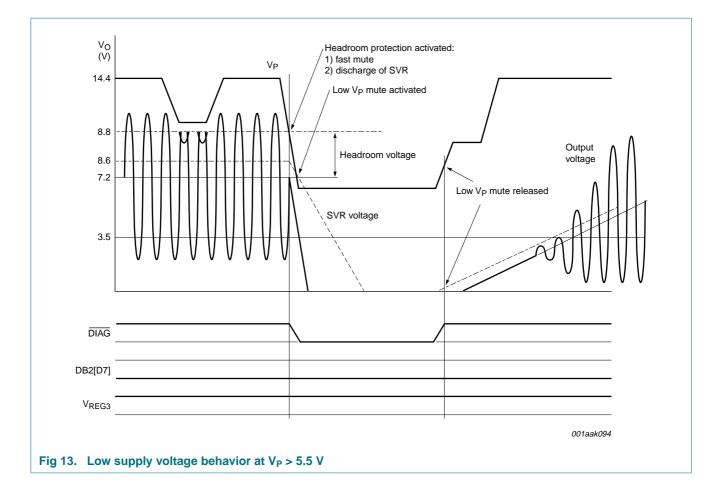
[7] Unbiased switch-supply I_{L} is measured in supply line $V_{P}.$

[8] Regulator output still in regulation at applied test voltage, therefore the actual dropout voltage can not be measured.

[9] The current capability of regulator 3 is sufficient to drive NXP Semiconductors' DSP devices SAF7730, SAF7740 or SAF7741.

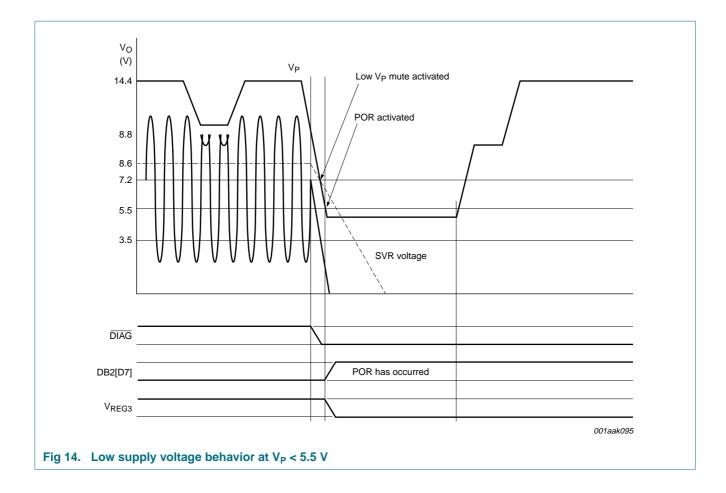


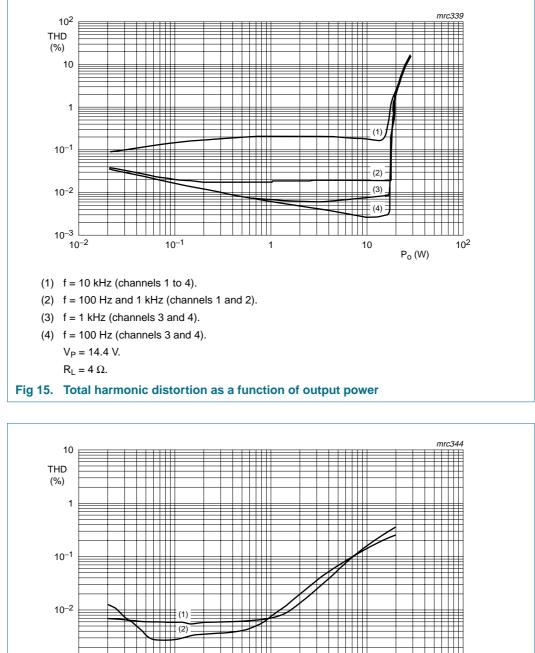


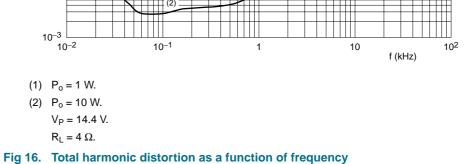


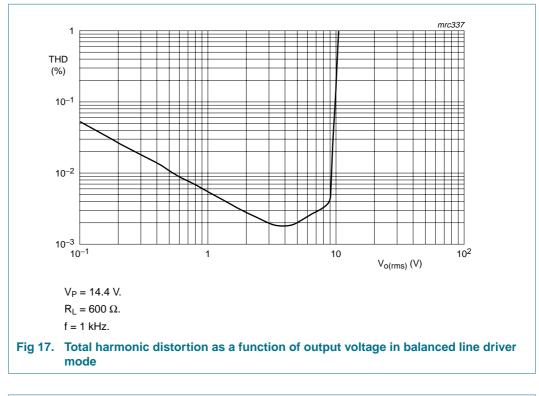
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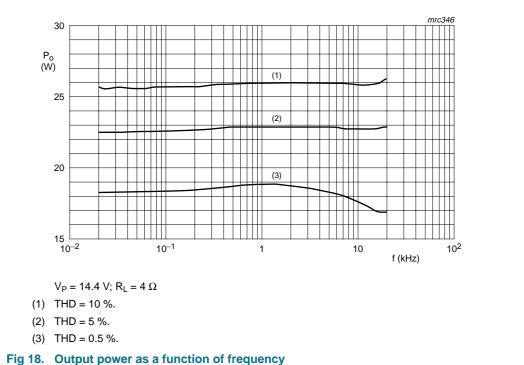
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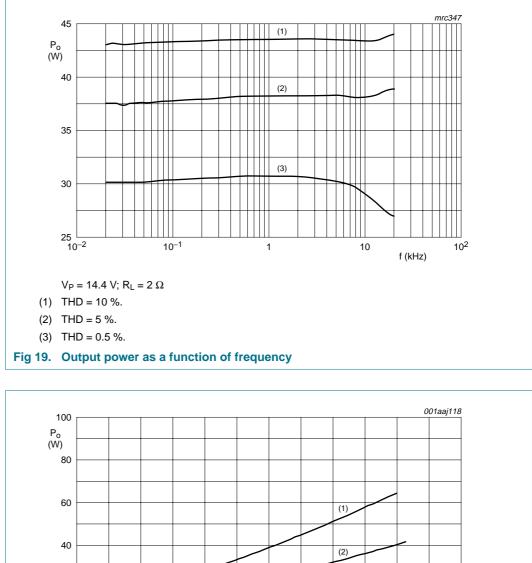


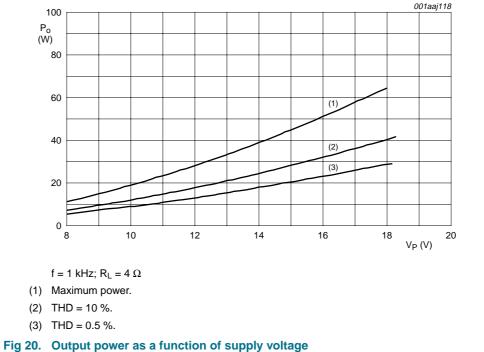






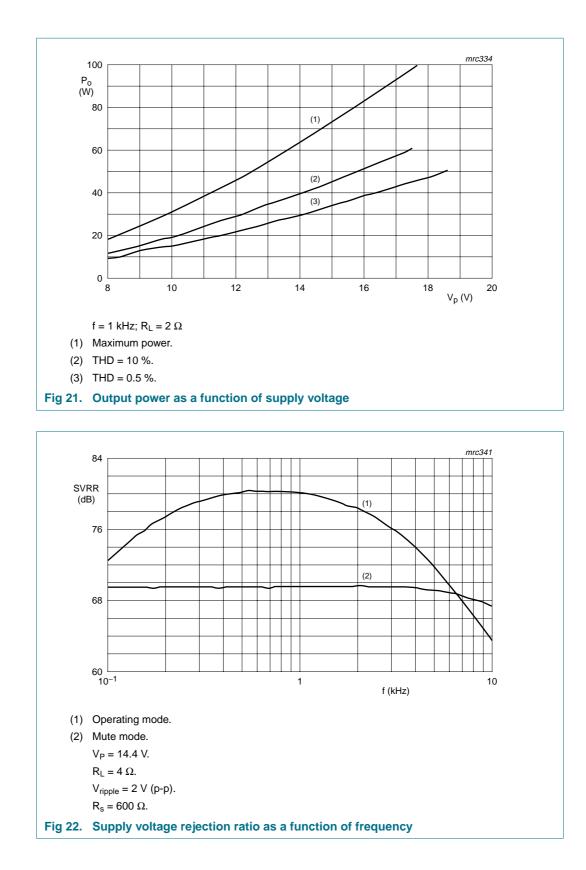


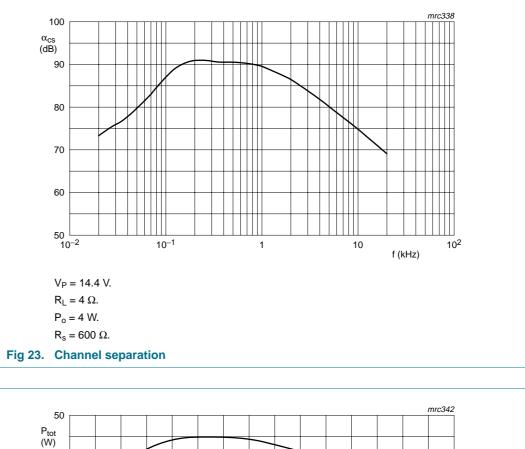


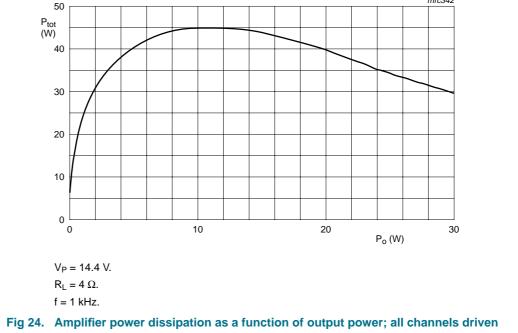


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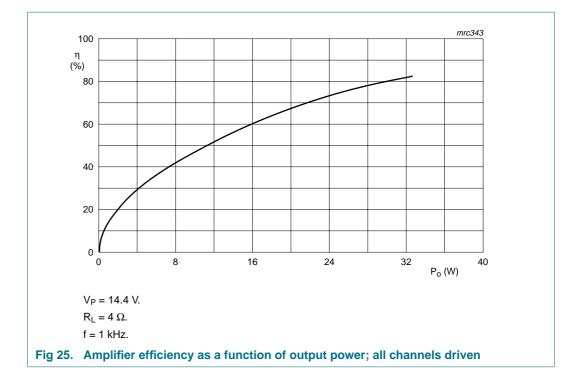






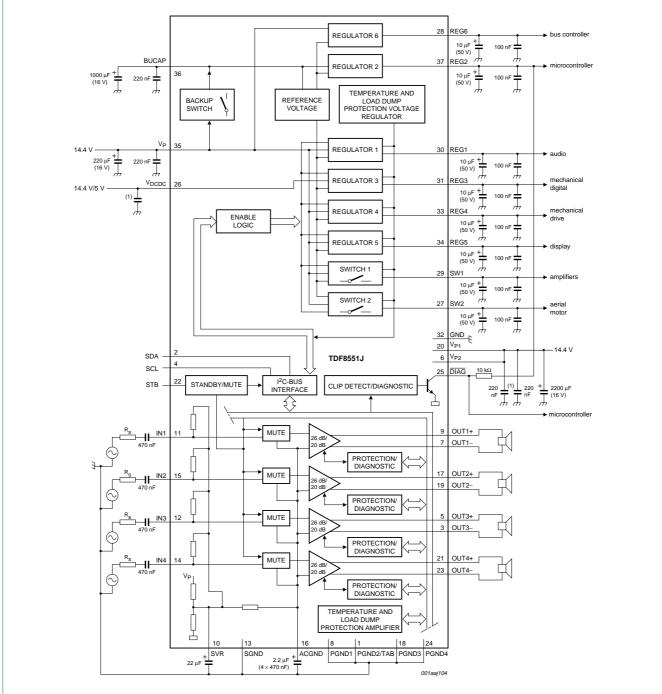
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 4×45 W power amplifier with six voltage regulators

12. Application information



(1) See <u>Section 12.1</u>.

The value of ACGND capacitor must be close to $4 \times$ the value of capacitor connected to the positive input of each channel; for EMC reasons a 10 nF capacitor can be connected between each amplifier output and ground.

Fig 26. Test and application diagram of TDF8551J

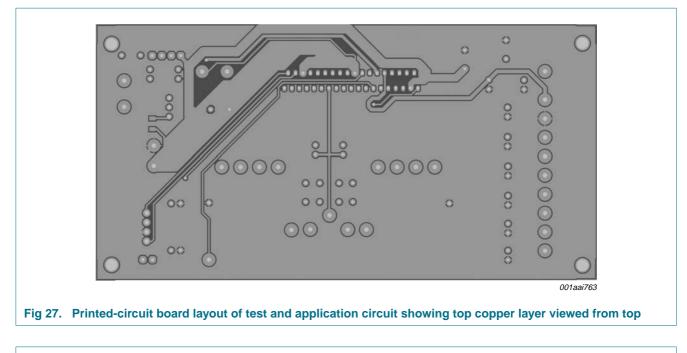
12.1 Supply decoupling

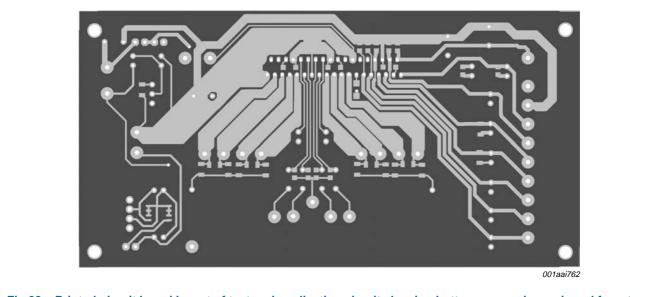
See <u>Figure 26</u> to <u>Figure 30</u>.

The high frequency 220 nF decoupling capacitors connected to power supply voltage pins 6 and 20 should be located as close as possible to these pins.

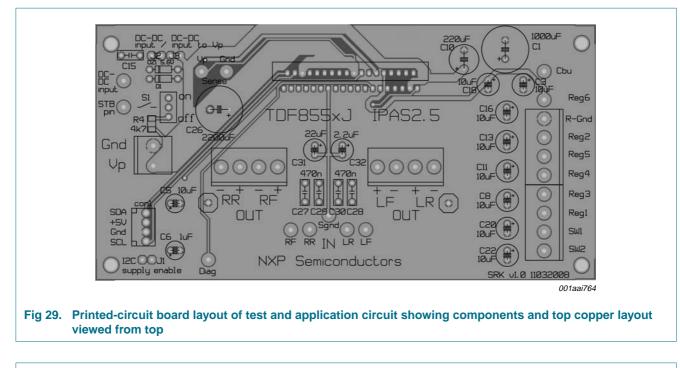
It is important to use good quality capacitors. These capacitors should be able to suppress high voltage peaks that can occur on the power supply if several audio channels are accidentally shorted to the power supply simultaneously, due to the activation of current protection. Good results have been achieved using 0805 case-size capacitors (X7R material, 220 nF) located close to power supply voltage pins 6 and 20.

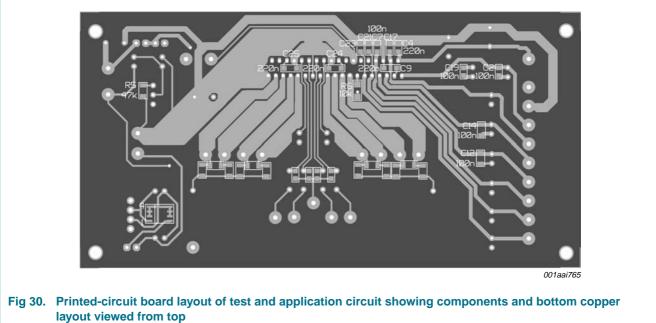
If a DC-to-DC converter is used to supply regulator 3, the recommendations of the converter manufacturer relating to decoupling must be followed.





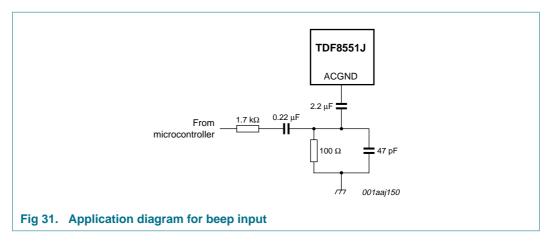






12.2 Beep input circuit

Beep input circuit to amplify the beep signal from the microcontroller to all 4 amplifiers (gain = 0 dB). Note that this circuit will not affect amplifier performance.



12.3 Noise

The outputs of regulators 1 to 6 are designed to give very low noise with good stability. The noise output voltage depends on output capacitor C_0 . Table 17 shows the effect of the output capacitor on the noise figure.

Regulator	Noise figure (μV) [1]						
	C _o = 10 μF	$C_o = 47 \ \mu F$	C _o = 100 μF				
1	225	180	145				
2	700	600	390				
3	100	85	65				
4	235	205	175				
5	315	285	225				
6	710	550	340				

Table 17. Regulator noise figures

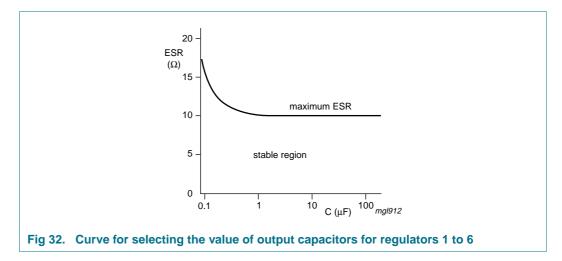
[1] Measured in the frequency range 20 Hz to 80 kHz; at $I_{O(req)} = 10$ mA.

12.4 Stability

The regulators are made stable by connecting capacitors to the regulator outputs. The stability can be guaranteed with almost any output capacitor if its Equivalent Series Resistance (ESR) stays below the ESR curve shown in Figure 32. If an electrolytic capacitor is used, its behavior with temperature can cause oscillations at extremely low temperature. Oscillation problems can be avoided by adding a 47 nF capacitor in parallel with the electrolytic capacitor. The following example describes how to select the value of output capacitor.

12.4.1 Example regulator 2

Regulator 2 is stabilized with an electrolytic output capacitor of 10 μ F which has an ESR of 4 Ω . At T_{amb} = -30 °C the capacitor value decreases to 3 μ F and its ESR increases to 28 Ω which is above the maximum allowed as shown in Figure 32, and which will make the regulator unstable. To avoid problems with stability at low temperatures, the recommended solution is to use tantalum capacitors. Either use a tantalum capacitor of 10 μ F, or an electrolytic capacitor with a higher value.



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13. Package outline

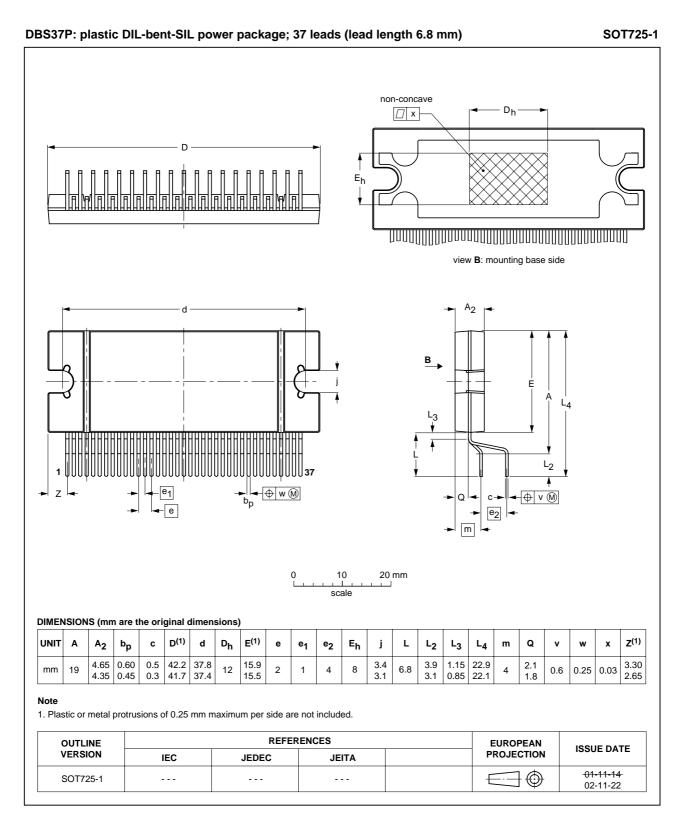


Fig 33. Package outline SOT725-1 (DBS37P)

14. Soldering of through-hole mount packages

14.1 Introduction to soldering through-hole mount packages

This text gives a very brief insight into wave, dip and manual soldering.

Wave soldering is the preferred method for mounting of through-hole mount IC packages on a printed-circuit board.

14.2 Soldering by dipping or by solder wave

Driven by legislation and environmental forces the worldwide use of lead-free solder pastes is increasing. Typical dwell time of the leads in the wave ranges from 3 seconds to 4 seconds at 250 °C or 265 °C, depending on solder material applied, SnPb or Pb-free respectively.

The total contact time of successive solder waves must not exceed 5 seconds.

The device may be mounted up to the seating plane, but the temperature of the plastic body must not exceed the specified maximum storage temperature ($T_{stg(max)}$). If the printed-circuit board has been pre-heated, forced cooling may be necessary immediately after soldering to keep the temperature within the permissible limit.

14.3 Manual soldering

Apply the soldering iron (24 V or less) to the lead(s) of the package, either below the seating plane or not more than 2 mm above it. If the temperature of the soldering iron bit is less than 300 °C it may remain in contact for up to 10 seconds. If the bit temperature is between 300 °C and 400 °C, contact may be up to 5 seconds.

14.4 Package related soldering information

Table 18.	Suitability of through-hole mount IC packages for dipping and wave solderin	g
-----------	---	---

Package	Soldering metho	Soldering method			
	Dipping	Wave			
CPGA, HCPGA	-	suitable			
DBS, DIP, HDIP, RDBS, SDIP, SIL	suitable	suitable ^[1]			
PMFP ^[2]	-	not suitable			

[1] For SDIP packages, the longitudinal axis must be parallel to the transport direction of the printed-circuit board.

[2] For PMFP packages hot bar soldering or manual soldering is suitable.

15. Abbreviations

AcronymDescriptionBCDMOSBipolar Complementary Double-diffused Metal-Oxide SemiconductorDSPDigital Signal ProcessorEMCElectroMagnetic CompatibilityLSBLeast Significant BitMSBMost Significant BitPORPower-On Reset	Table 19. A	bbreviations
DSPDigital Signal ProcessorEMCElectroMagnetic CompatibilityLSBLeast Significant BitMSBMost Significant Bit	Acronym	Description
EMCElectroMagnetic CompatibilityLSBLeast Significant BitMSBMost Significant Bit	BCDMOS	Bipolar Complementary Double-diffused Metal-Oxide Semiconductor
LSBLeast Significant BitMSBMost Significant Bit	DSP	Digital Signal Processor
MSB Most Significant Bit	EMC	ElectroMagnetic Compatibility
	LSB	Least Significant Bit
POR Power-On Reset	MSB	Most Significant Bit
	POR	Power-On Reset

16. Revision history

Table 20. Revision	history			
Document ID	Release date	Data sheet status	Change notice	Supersedes
TDF8551J_2	20090818	Product data sheet	-	TDF8551J_1
Modifications:	 Table 16 "C 	haracteristics" changed mini	mum output current (I _O) regulator 3 pin REG3.
TDF8551J_1	20081202	Preliminary data sheet	-	-

17. Legal information

17.1 Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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